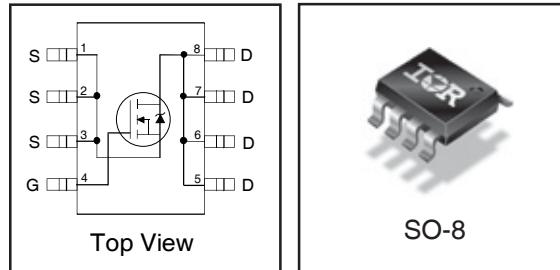


<b>V<sub>DS</sub></b>	<b>30</b>	<b>V</b>
<b>R<sub>DS(on)</sub> max</b> (@V <sub>GS</sub> = 10V)	<b>2.8</b>	<b>mΩ</b>
<b>R<sub>DS(on)</sub> max</b> (@V <sub>GS</sub> = 4.5V)	<b>3.8</b>	
<b>Q<sub>g</sub> (typical)</b>	<b>44</b>	<b>nC</b>
<b>I<sub>D</sub></b> (@T <sub>A</sub> = 25°C)	<b>24</b>	<b>A</b>



#### Features

Industry-standard pinout SO-8 Package
Compatible with Existing Surface Mount Techniques
RoHS Compliant, Halogen-Free
MSL1, Industrial qualification

#### Benefits

⇒	Multi-Vendor Compatibility
	Easier Manufacturing
	Environmentally Friendlier
	Increased Reliability

Base Part Number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
IRF8788PbF-1	SO-8	Tube/Bulk	95	IRF8788PbF-1
		Tape and Reel	4000	IRF8788TRPbF-1

#### Absolute Maximum Ratings

	Parameter	Max.	Units
V <sub>DS</sub>	Drain-to-Source Voltage	30	V
V <sub>GS</sub>	Gate-to-Source Voltage	±20	
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	24	A
I <sub>D</sub> @ T <sub>A</sub> = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	19	
I <sub>DM</sub>	Pulsed Drain Current ①	190	
P <sub>D</sub> @ T <sub>A</sub> = 25°C	Power Dissipation	2.5	W
P <sub>D</sub> @ T <sub>A</sub> = 70°C	Power Dissipation	1.6	
	Linear Derating Factor	0.02	W/°C
T <sub>J</sub>	Operating Junction and	-55 to + 150	
T <sub>STG</sub>	Storage Temperature Range		°C

#### Thermal Resistance

	Parameter	Typ.	Max.	Units
R <sub>θJL</sub>	Junction-to-Drain Lead ⑤	—	20	°C/W
R <sub>θJA</sub>	Junction-to-Ambient ④⑤	—	50	

Notes ① through ⑤ are on page 9

**Static @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

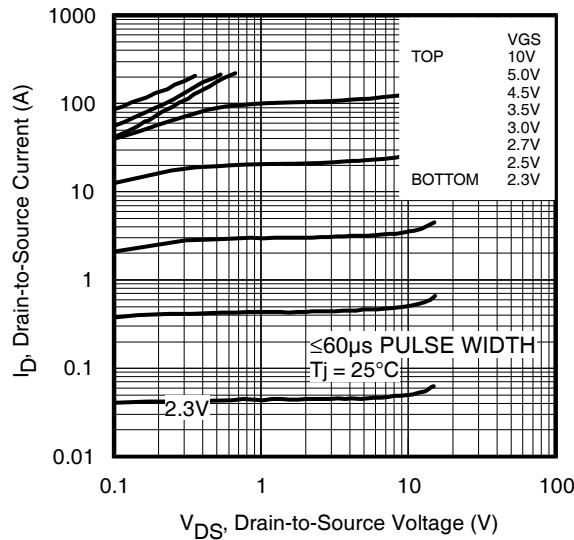
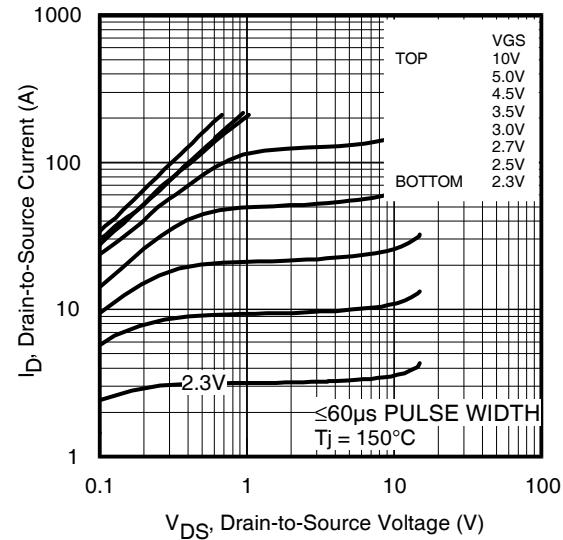
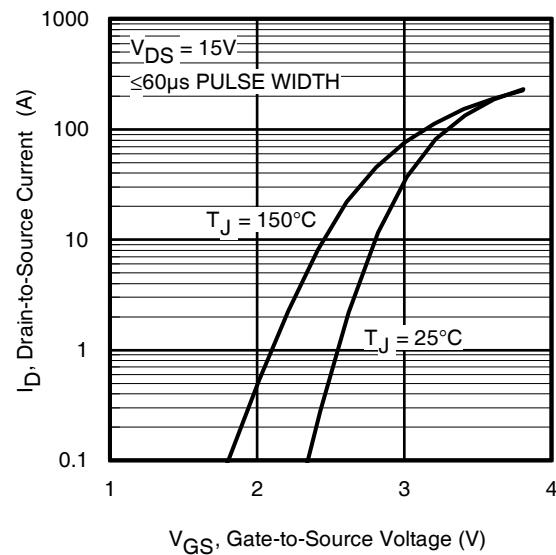
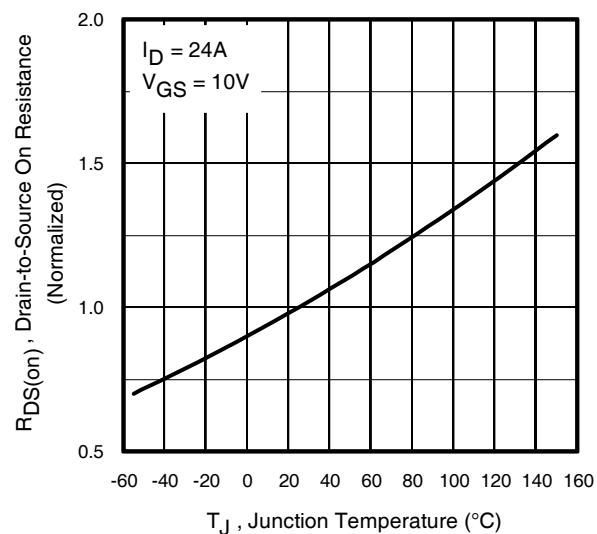
	Parameter	Min.	Typ.	Max.	Units	Conditions
$\text{BV}_{\text{DSS}}$	Drain-to-Source Breakdown Voltage	30	—	—	V	$\text{V}_{\text{GS}} = 0\text{V}$ , $I_D = 250\mu\text{A}$
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.024	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	2.3	2.8	$\text{m}\Omega$	$\text{V}_{\text{GS}} = 10\text{V}$ , $I_D = 24\text{A}$ ③
		—	3.04	3.8		$\text{V}_{\text{GS}} = 4.5\text{V}$ , $I_D = 19\text{A}$ ③
$\text{V}_{\text{GS}(\text{th})}$	Gate Threshold Voltage	1.35	1.80	2.35	V	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}$ , $I_D = 100\mu\text{A}$
$\Delta \text{V}_{\text{GS}(\text{th})}$	Gate Threshold Voltage Coefficient	—	-6.59	—	mV/ $^\circ\text{C}$	
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	1.0	$\mu\text{A}$	$\text{V}_{\text{DS}} = 24\text{V}$ , $\text{V}_{\text{GS}} = 0\text{V}$
		—	—	150		$\text{V}_{\text{DS}} = 24\text{V}$ , $\text{V}_{\text{GS}} = 0\text{V}$ , $T_J = 125^\circ\text{C}$
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	100	$\text{nA}$	$\text{V}_{\text{GS}} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$\text{V}_{\text{GS}} = -20\text{V}$
$g_{\text{fs}}$	Forward Transconductance	95	—	—	S	$\text{V}_{\text{DS}} = 15\text{V}$ , $I_D = 19\text{A}$
$Q_g$	Total Gate Charge	—	44	66	nC	$\text{V}_{\text{DS}} = 15\text{V}$ $\text{V}_{\text{GS}} = 4.5\text{V}$ $I_D = 19\text{A}$ See Figs. 17a & 17b
$Q_{\text{gs}1}$	Pre-V <sub>th</sub> Gate-to-Source Charge	—	12	—		
$Q_{\text{gs}2}$	Post-V <sub>th</sub> Gate-to-Source Charge	—	4.7	—		
$Q_{\text{gd}}$	Gate-to-Drain Charge	—	14	—		
$Q_{\text{godr}}$	Gate Charge Overdrive	—	13.3	—		
$Q_{\text{sw}}$	Switch Charge ( $Q_{\text{gs}2} + Q_{\text{gd}}$ )	—	18.7	—	nC	$\text{V}_{\text{DS}} = 16\text{V}$ , $\text{V}_{\text{GS}} = 0\text{V}$
$Q_{\text{oss}}$	Output Charge	—	22	—		
$R_g$	Gate Resistance	—	0.54	1.09		
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	23	—	ns	$\text{V}_{\text{DD}} = 15\text{V}$ , $\text{V}_{\text{GS}} = 4.5\text{V}$ $I_D = 19\text{A}$ $R_G = 1.8\Omega$ See Fig. 15a & 15b
$t_r$	Rise Time	—	24	—		
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	23	—		
$t_f$	Fall Time	—	11	—		
$C_{\text{iss}}$	Input Capacitance	—	5720	—	pF	$\text{V}_{\text{GS}} = 0\text{V}$ $\text{V}_{\text{DS}} = 15\text{V}$ $f = 1.0\text{MHz}$
$C_{\text{oss}}$	Output Capacitance	—	980	—		
$C_{\text{rss}}$	Reverse Transfer Capacitance	—	450	—		

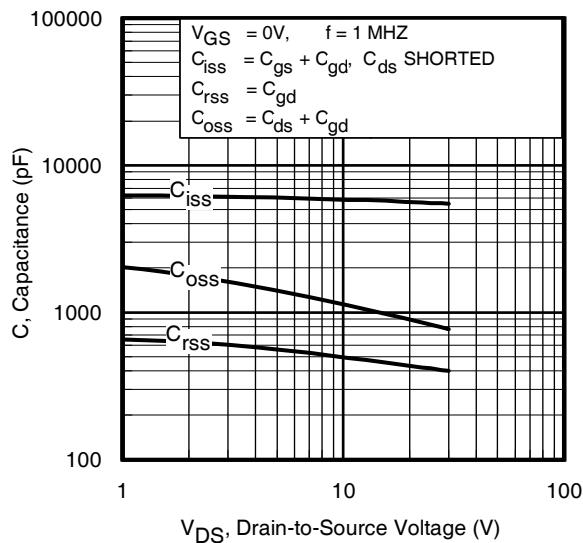
**Avalanche Characteristics**

	Parameter	Typ.	Max.	Units
$E_{\text{AS}}$	Single Pulse Avalanche Energy ②	—	230	mJ
$I_{\text{AR}}$	Avalanche Current ①	—	19	A

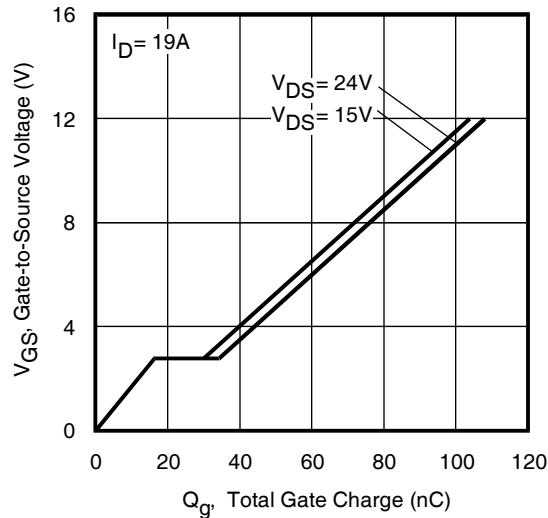
**Diode Characteristics**

	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	3.1	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{\text{SM}}$	Pulsed Source Current (Body Diode) ①	—	—	190	A	
$V_{\text{SD}}$	Diode Forward Voltage	—	—	1.0	V	$T_J = 25^\circ\text{C}$ , $I_S = 19\text{A}$ , $\text{V}_{\text{GS}} = 0\text{V}$ ③
		—	—	0.75	V	$T_J = 25^\circ\text{C}$ , $I_S = 2.2\text{A}$ , $\text{V}_{\text{GS}} = 0\text{V}$ ③
$t_{\text{rr}}$	Reverse Recovery Time	—	24	36	ns	$T_J = 25^\circ\text{C}$ , $I_F = 19\text{A}$ , $\text{V}_{\text{DD}} = 15\text{V}$
$Q_{\text{rr}}$	Reverse Recovery Charge	—	33	50	nC	$\text{di}/\text{dt} = 230\text{A}/\mu\text{s}$ ③
$t_{\text{on}}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

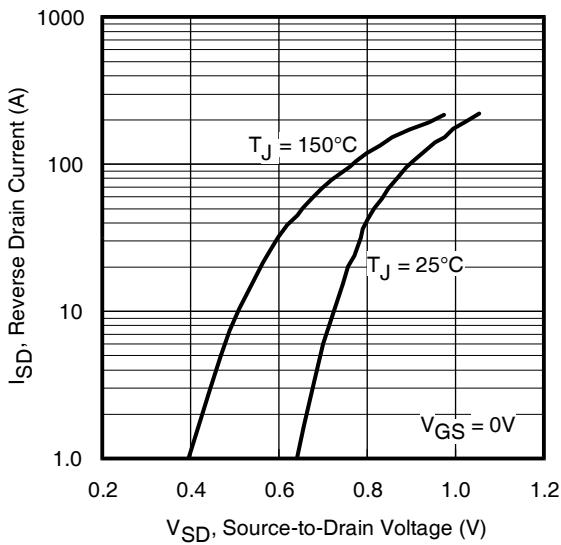
**Fig 1.** Typical Output Characteristics**Fig 2.** Typical Output Characteristics**Fig 3.** Typical Transfer Characteristics**Fig 4.** Normalized On-Resistance vs. Temperature



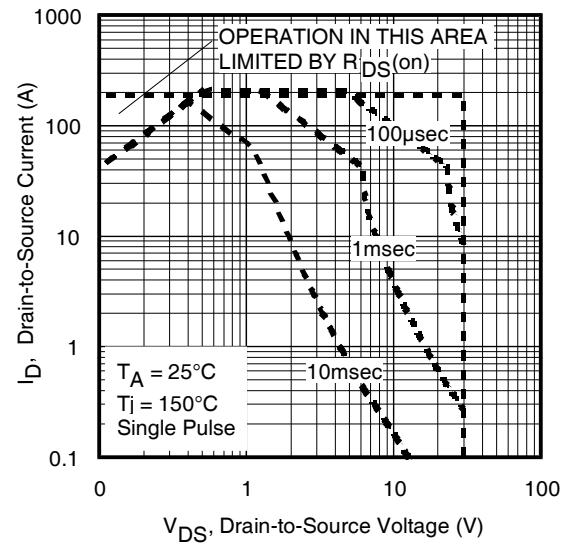
**Fig 5.** Typical Capacitance vs.  
Drain-to-Source Voltage



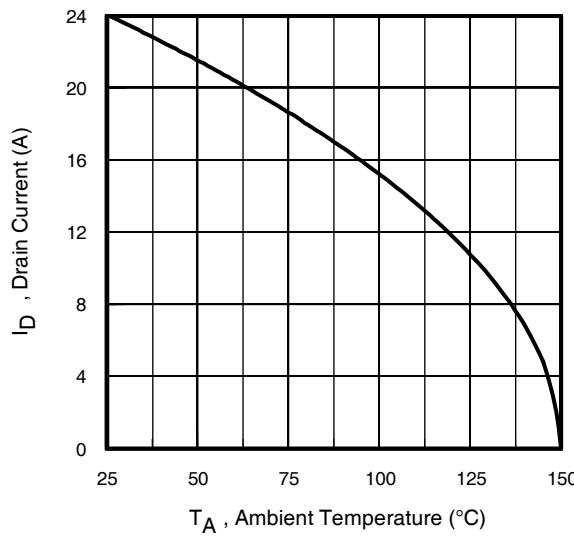
**Fig 6.** Typical Gate Charge vs.  
Gate-to-Source Voltage



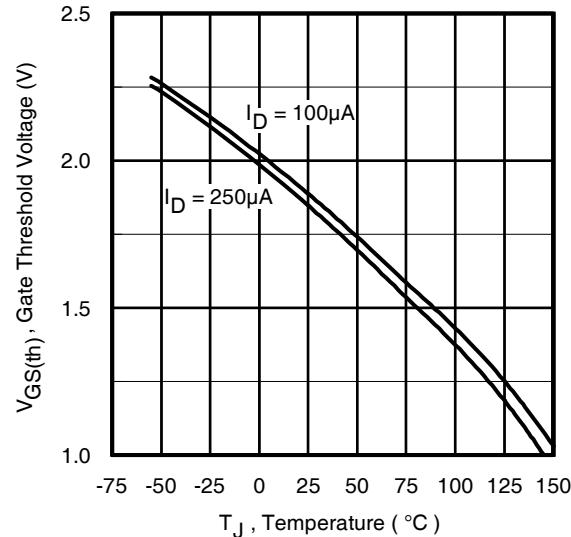
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



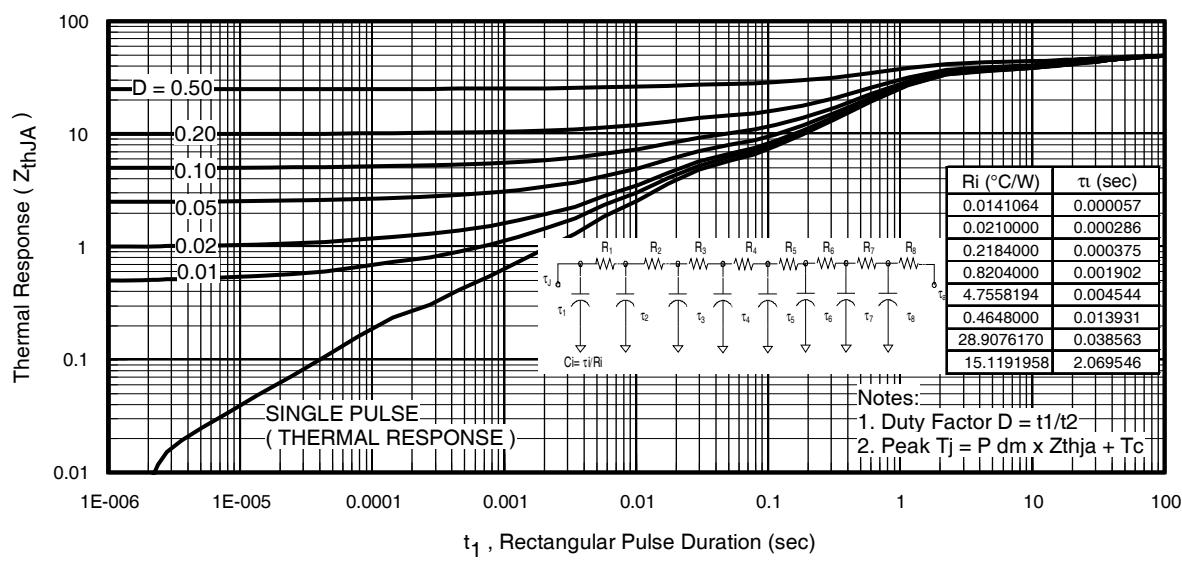
**Fig 8.** Maximum Safe Operating Area



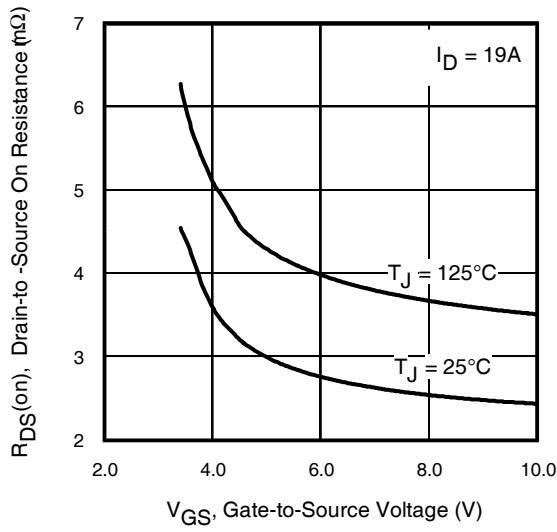
**Fig 9.** Maximum Drain Current vs.  
Ambient Temperature



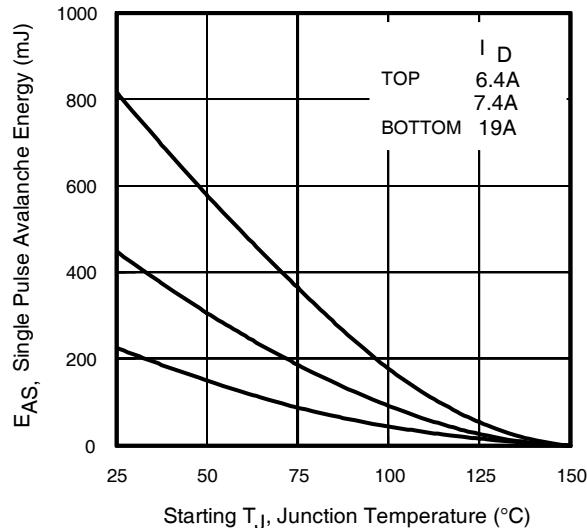
**Fig 10.** Threshold Voltage vs. Temperature



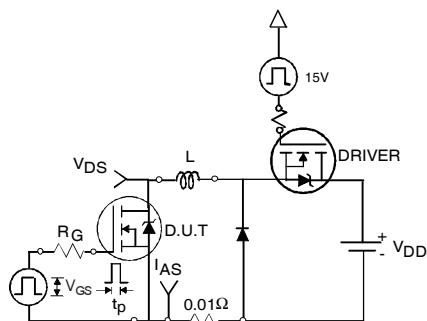
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



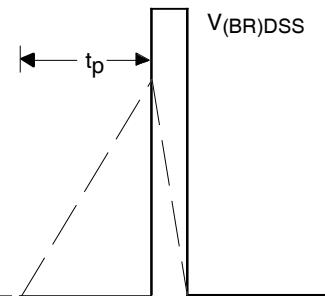
**Fig 12.** On-Resistance vs. Gate Voltage



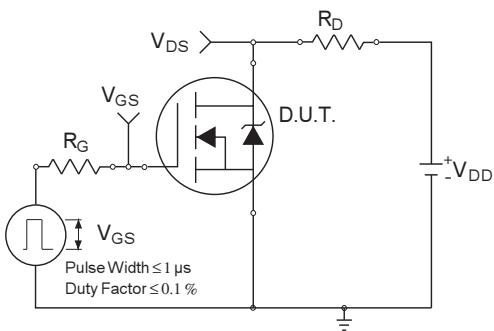
**Fig 13.** Maximum Avalanche Energy vs. Drain Current



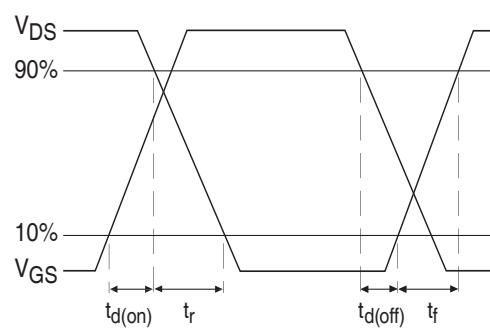
**Fig 14a.** Unclamped Inductive Test Circuit



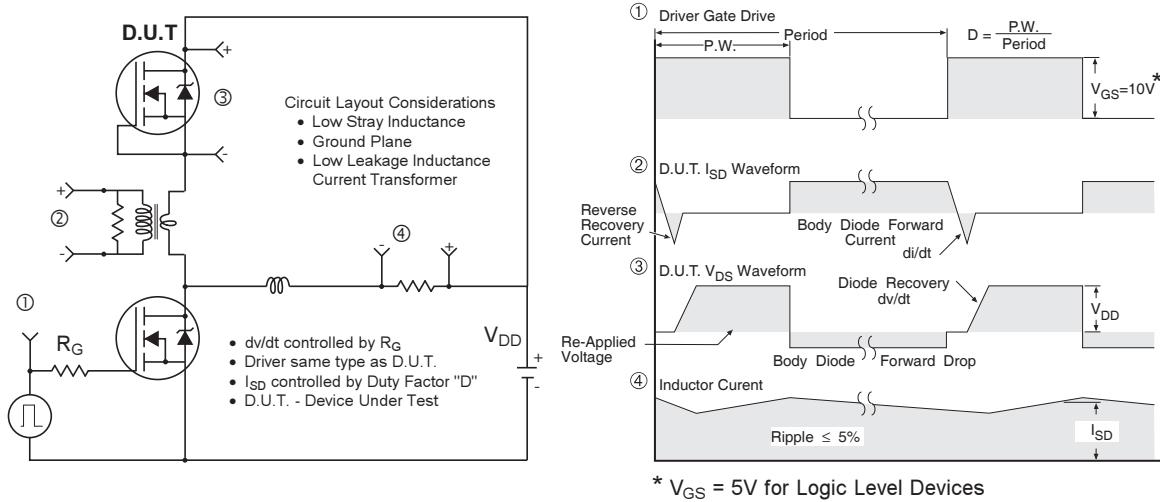
**Fig 14b.** Unclamped Inductive Waveforms



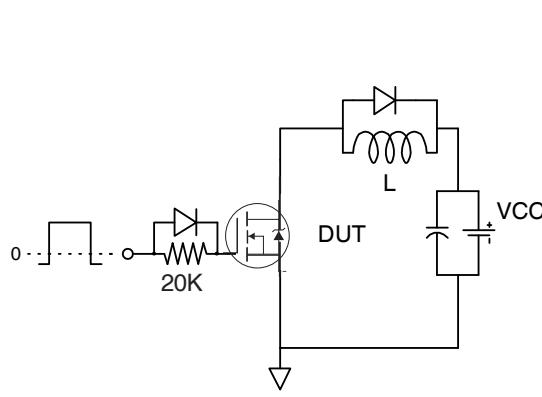
**Fig 15a.** Switching Time Test Circuit



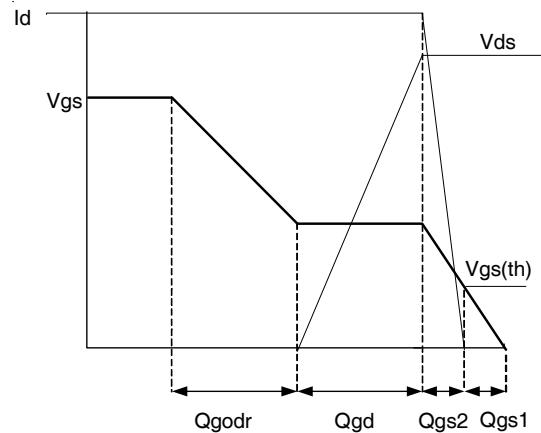
**Fig 15b.** Switching Time Waveforms



**Fig 16.** Peak Diode Recovery  $dv/dt$  Test Circuit for N-Channel HEXFET® Power MOSFETs



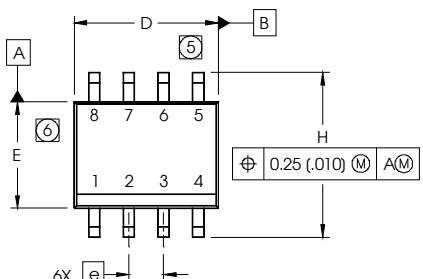
**Fig 17a.** Gate Charge Test Circuit



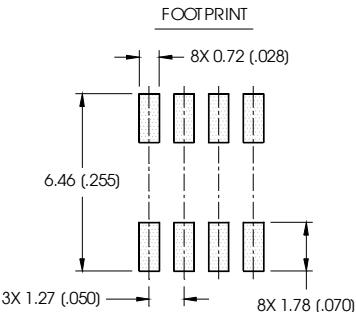
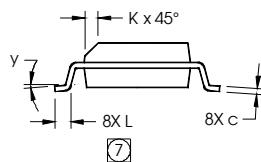
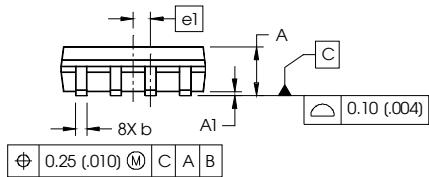
**Fig 17b.** Gate Charge Waveform

## SO-8 Package Outline (Mosfet & Fetky)

Dimensions are shown in millimeters (inches)



DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.0532	.0688	1.35	1.75
A1	.0040	.0098	0.10	0.25
b	.013	.020	0.33	0.51
c	.0075	.0098	0.19	0.25
D	.189	.1968	4.80	5.00
E	.1497	.1574	3.80	4.00
e	.050	BASIC	1.27	BASIC
e1	.025	BASIC	0.635	BASIC
H	.2284	.2440	5.80	6.20
K	.0099	.0196	0.25	0.50
L	.016	.050	0.40	1.27
Y	0°	8°	0°	8°

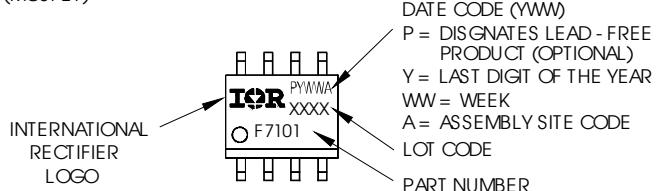


### NOTES:

1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: MILLIMETER
3. DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
5. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.15 (.006).
6. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.25 (.010).
7. DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.

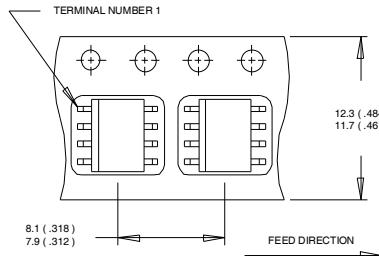
## SO-8 Part Marking Information

EXAMPLE: THIS IS AN IRF7101 (MOSFET)

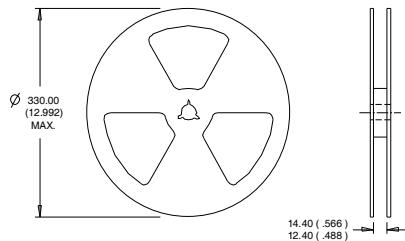


Note: For the most current drawing please refer to IR website at: <http://www.irf.com/package/>

## SO-8 Tape and Reel (Dimensions are shown in milimeters (inches))



NOTES:  
 1. CONTROLLING DIMENSION : MILLIMETER.  
 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).  
 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES :  
 1. CONTROLLING DIMENSION : MILLIMETER.  
 2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

**Note:** For the most current drawing please refer to IR website at: <http://www.irf.com/package/>

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 1.25\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 19\text{A}$ .
- ③ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ④ When mounted on 1 inch square copper board.
- ⑤  $R_\theta$  is measured at  $T_J$  of approximately  $90^\circ\text{C}$ .

### Qualification information<sup>†</sup>

Qualification level	Industrial (per JEDEC JESD47F <sup>††</sup> guidelines)	
Moisture Sensitivity Level	SO-8	ML1 (per JEDEC J-STD-020D <sup>††</sup> )
RoHS compliant	Yes	

<sup>†</sup> Qualification standards can be found at International Rectifier's web site: <http://www.irf.com/product-info/reliability>

<sup>††</sup> Applicable version of JEDEC standard at the time of product release

International  
IR Rectifier

**IR WORLD HEADQUARTERS:** 101 N. Sepulveda Blvd., El Segundo, California 90245, USA  
 To contact International Rectifier, please visit <http://www.irf.com/whoto-call/>